Search Notes



Application/Control No.	Applicant(s)/Patent unde Reexamination	r
10/669,326	NAKANO, MANABU	
Examiner	Art Unit	
Christopher B. Shin	2182	

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SEARCHED				
Class	Subclass	Date	Examiner	
370	464-467	7/21/2005	CBS	
710	8-14	7/21/2005	CBS	
710	15-19	7/21/2005	CBS	
710	36-38	7/21/2005	CBS	
710	62-64	7/21/2005	CBS	
710	71-74	7/21/2005	CBS	
710	305-316	7/21/2005	CBS	
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
710	65, 11	2-8-06	or		
710	14, 315		1		
370	466	+	+		
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
PLUS ·	7/21/2005	CBS
PALM-DOUBLE PATENTING	7/21/2005	CBS
EAST (US-PGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB)	7/21/2005	CBS
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